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Loewe, Sun Jae Y

1626

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SEARCH NOTES		
Search Notes	Date	Examiner
restriction requirement	1-26-2008	sl
stn: registry & caplus	4-18-2008	sl
palm all inventors	4-21-2008	sl
STN: registry & caplus updated	10-17-2008	sl
PALM all inventors updated	10-17-2008	sl
STN registry & caplus updated	7-18-2009	sl
PALM all inventors updated	7-18-2009	sl

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